

74ALVT16823

18-bit bus-interface D-type flip-flop with reset and enable;
3-state

Rev. 04 — 2 August 2005

Product data sheet

1. General description

The 74ALVT16823 18-bit bus interface register is designed to eliminate the extra packages required to buffer existing registers and provide extra data width for wider data/address paths of buses carrying parity.

The 74ALVT16823 has two 9-bit wide buffered registers with clock enable (pin $\overline{nCE}$) and master reset (pin $\overline{nMR}$) which are ideal for parity bus interfacing in high microprogrammed systems.

The registers are fully edge-triggered. The state of each D input, one set-up time before the LOW-to-HIGH clock transition is transferred to the corresponding Q output of the flip-flop.

It is designed for V_{CC} operation from 2.5 V to 3.0 V with I/O compatibility to 5 V.

2. Features

- Two sets of high speed parallel registers with positive edge-triggered D-type flip-flops
- 5 V I/O compatible
- Ideal where high speed, light loading, or increased fan-in are required with MOS microprocessors
- Bus hold data inputs eliminate the need for external pull-up resistors to hold unused inputs
- Live insertion and extraction permitted
- Power-up 3-state
- Power-up reset
- No bus current loading when output is tied to 5 V bus
- Output capability: +64 mA to –32 mA
- Latch-up protection:
 - ◆ JESD78: exceeds 500 mA
- ESD protection:
 - ◆ MIL STD 883, method 3015: exceeds 2000 V
 - ◆ Machine Model: exceeds 200 V

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3. Quick reference data

Table 1: Quick reference data

$T_{amb} = 25\text{ }^{\circ}\text{C}$.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
t_{PLH}	propagation delay nCP to nQx	$C_L = 50\text{ pF}$; $V_{CC} = 2.5\text{ V}$	1.5	2.9	4.5	ns
		$C_L = 50\text{ pF}$; $V_{CC} = 3.3\text{ V}$	1.0	2.3	3.1	ns
t_{PHL}	propagation delay nCP to nQx	$C_L = 50\text{ pF}$; $V_{CC} = 2.5\text{ V}$	1.4	2.7	4.2	ns
		$C_L = 50\text{ pF}$; $V_{CC} = 3.3\text{ V}$	1.0	2.1	2.9	ns
C_i	input capacitance	$V_I = 0\text{ V}$ or V_{CC}	-	3	-	pF
C_o	output capacitance	$V_{IO} = 0\text{ V}$ or V_{CC}	-	9	-	pF
I_{CC}	quiescent supply current	outputs disabled; $V_{CC} = 2.5\text{ V}$	-	40	-	μA
		outputs disabled; $V_{CC} = 3.3\text{ V}$	-	70	-	μA

4. Ordering information

Table 2: Ordering information

Type number	Package			
	temperature range	Name	Description	Version
74ALVT16823DL	$-40\text{ }^{\circ}\text{C}$ to $+85\text{ }^{\circ}\text{C}$	SSOP56	plastic shrink small outline package; 56 leads; body width 7.5 mm	SOT371-1
74ALVT16823DGG	$-40\text{ }^{\circ}\text{C}$ to $+85\text{ }^{\circ}\text{C}$	TSSOP56	plastic thin shrink small outline package; 56 leads; body width 6.1 mm	SOT364-1



5. Functional diagram

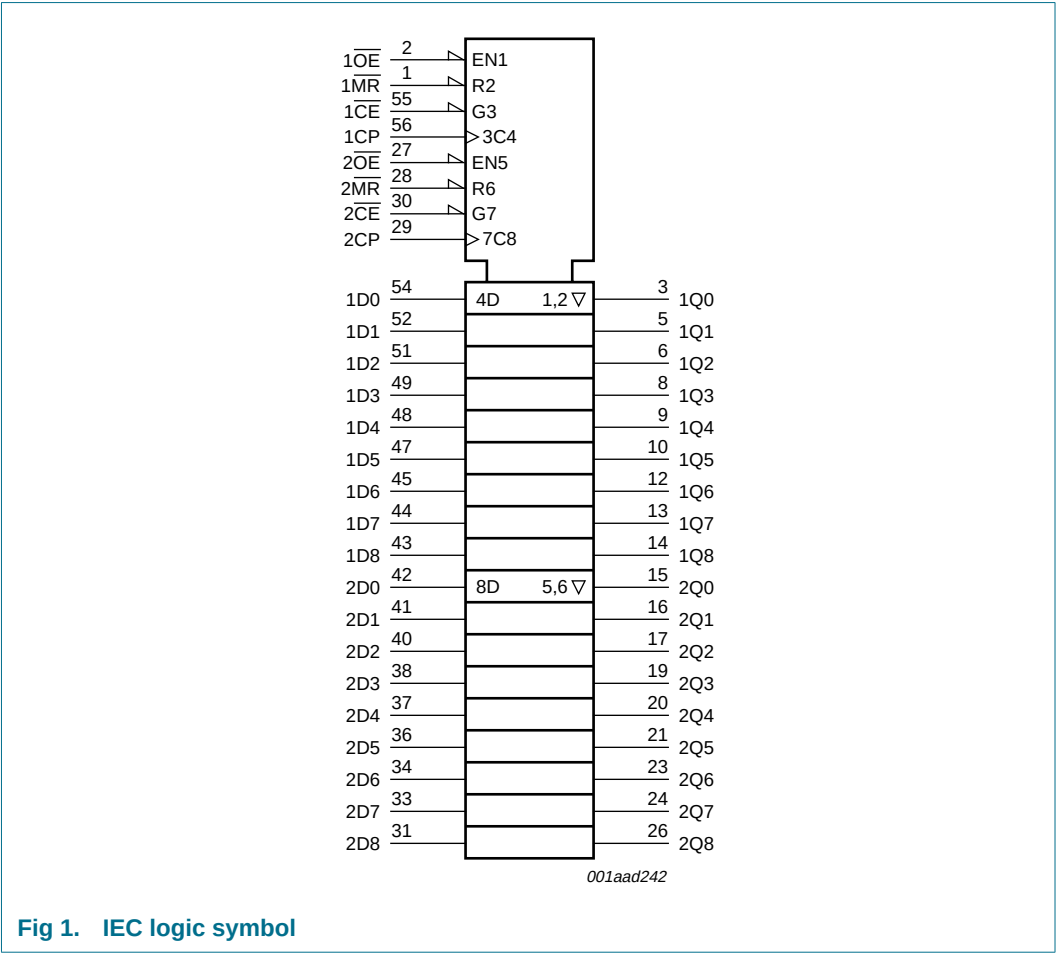


Fig 1. IEC logic symbol

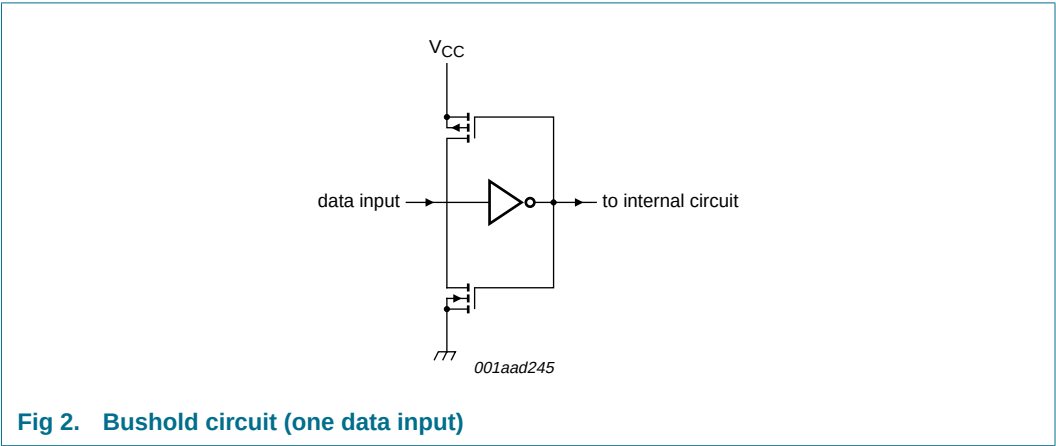


Fig 2. Bushold circuit (one data input)

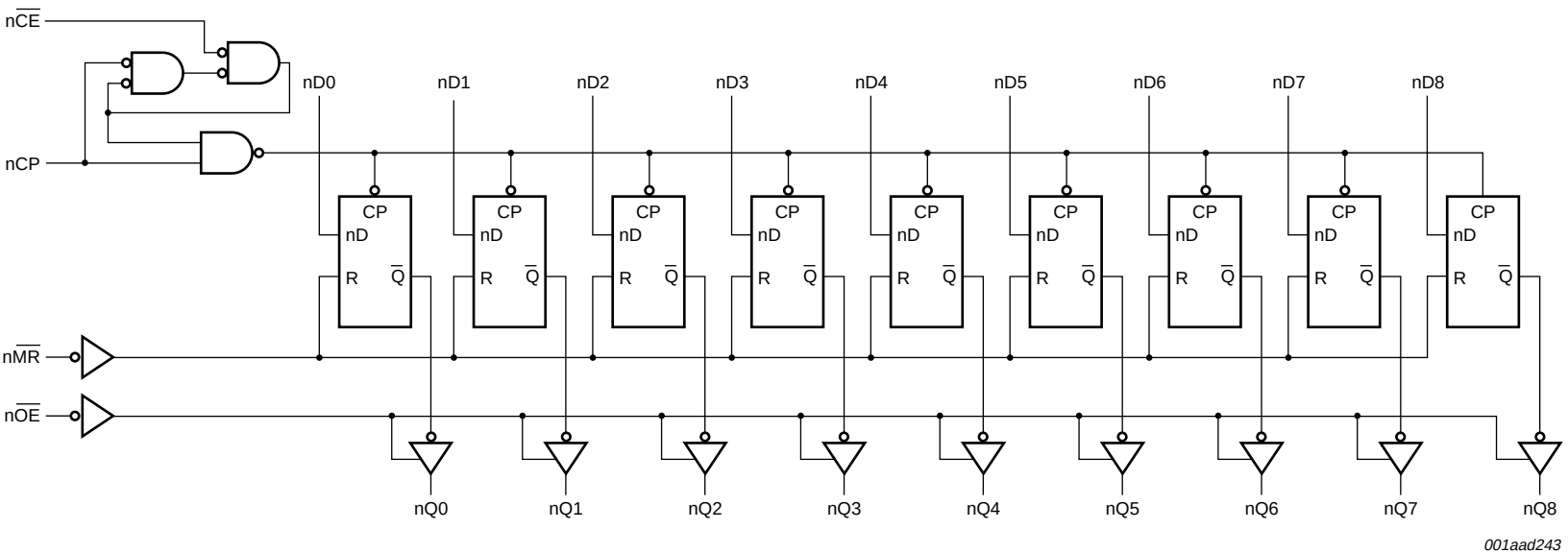


Fig 3. Logic diagram



Table 3: Pin description ...continued

Symbol	Pin	Description
1Q4	9	1 data output 4
1Q5	10	1 data output 5
GND	11	ground (0 V)
1Q6	12	1 data output 6
1Q7	13	1 data output 7
1Q8	14	1 data output 8
2Q0	15	2 data output 0
2Q1	16	2 data output 1
2Q2	17	2 data output 2
GND	18	ground (0 V)
2Q3	19	2 data output 3
2Q4	20	2 data output 4
2Q5	21	2 data output 5
V _{CC}	22	supply voltage
2Q6	23	2 data output 6
2Q7	24	2 data output 7
GND	25	ground (0 V)
2Q8	26	2 data output 8
2 $\overline{OE}$	27	2 output enable input (active-LOW)
2 $\overline{MR}$	28	2 master reset input (active-LOW)
2CP	29	2 clock pulse input (active rising edge)
2 $\overline{CE}$	30	2 clock enable input (active-LOW)
2D8	31	2 data input 8
GND	32	ground (0 V)
2D7	33	2 data input 7
2D6	34	2 data input 6
V _{CC}	35	supply voltage
2D5	36	2 data input 5
2D4	37	2 data input 4
2D3	38	2 data input 3
GND	39	ground (0 V)
2D2	40	2 data input 2
2D1	41	2 data input 1
2D0	42	2 data input 0
1D8	43	1 data input 8
1D7	44	1 data input 7
1D6	45	1 data input 6
GND	46	ground (0 V)
1D5	47	1 data input 5
1D4	48	1 data input 4
1D3	49	1 data input 3

Table 3: Pin description ...continued

Symbol	Pin	Description
V _{CC}	50	supply voltage
1D2	51	1 data input 2
1D1	52	1 data input 1
GND	53	ground (0 V)
1D0	54	1 data input 0
1 $\overline{\text{CE}}$	55	1 clock enable input (active-LOW)
1CP	56	1 clock pulse input (active rising edge)

7. Functional description

7.1 Function table

Table 4: Function table

Operating mode	Input					Output
	n $\overline{\text{OE}}$	n $\overline{\text{MR}}$	n $\overline{\text{CE}}$	nCP	nDx	nQx
clear	L	L	X	X	X	L
load and read data	L	H	L	$\uparrow$	h	H
					l	L
hold	L	H	H	$\uparrow$	X	NC
high-impedance	H	X	X	X	X	Z

- [1] H = HIGH voltage level;
h = HIGH voltage level one set-up time prior to the LOW-to-HIGH clock transition;
L = LOW voltage level;
l = LOW voltage level one set-up time prior to the LOW-to-HIGH clock transition;
NC = no change;
X = don't care;
Z = high-impedance OFF-state;
 $\uparrow$ = LOW-to-HIGH clock transition;
 $\uparrow$ = not a LOW-to-HIGH clock transition.

8. Limiting values

Table 5: Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V _{CC}	supply voltage		−0.5	+4.6	V
V _I	input voltage		[1] −0.5	+7.0	V
V _O	output voltage	output in OFF-state or HIGH-state	[1] −0.5	+7.0	V
I _{IK}	input diode current	V _I < 0 V	−50	-	mA
I _{OK}	output diode current	V _O < 0 V	−50	-	mA

Table 5: Limiting values ...continued

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
I_O	output current	output in LOW-state	-	128	mA
		output in HIGH-state	-64	-	mA
T_{stg}	storage temperature		-65	+150	°C
T_j	junction temperature	[2]	-	150	°C

[1] The input and output negative voltage ratings may be exceeded if the input and output clamp current ratings are observed.

[2] The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability.

9. Recommended operating conditions

Table 6: Recommended operating conditions

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$V_{CC} = 2.5\text{ V}$						
V_{CC}	supply voltage		2.3	-	2.7	V
V_I	input voltage		0	-	5.5	V
V_{IH}	HIGH-level input voltage		1.7	-	-	V
V_{IL}	LOW-level input voltage		-	-	0.7	V
I_{OH}	HIGH-level output current		-	-	-8	mA
I_{OL}	LOW-level output current	none	-	-	8	mA
		current duty cycle $\leq 50\%$; $f \geq 1\text{ kHz}$	-	-	24	mA
$\Delta t/\Delta v$	input transition rise or fall rate	outputs enabled	-	-	10	ns/V
T_{amb}	ambient temperature	in free air	-40	-	+85	°C
$V_{CC} = 3.3\text{ V}$						
V_{CC}	supply voltage		3.0	-	3.6	V
V_I	input voltage		0	-	5.5	V
V_{IH}	HIGH-level input voltage		2.0	-	-	V
V_{IL}	LOW-level input voltage		-	-	0.8	V
I_{OH}	HIGH-level output current		-	-	-32	mA
I_{OL}	LOW-level output current	none	-	-	32	mA
		current duty cycle $\leq 50\%$; $f \geq 1\text{ kHz}$	-	-	64	mA
$\Delta t/\Delta v$	input transition rise or fall rate	outputs enabled	-	-	10	ns/V
T_{amb}	ambient temperature	in free air	-40	-	+85	°C

10. Static characteristics

Table 7: Static characteristics

At recommended operating conditions; voltages are referenced to GND (ground = 0 V); $T_{amb} = -40^{\circ}\text{C}$ to $+85^{\circ}\text{C}$.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$V_{CC} = 2.5\text{ V} \pm 0.2\text{ V}$ [4]						
V_{IK}	input clamping voltage	$V_{CC} = 2.3\text{ V}$; $I_{IK} = -18\text{ mA}$	-	-0.85	-1.2	V
V_{OH}	HIGH-level output voltage	$V_{CC} = 2.3\text{ V}$ to 2.7 V ; $I_{OH} = -100\text{ }\mu\text{A}$	$V_{CC} - 0.2$	V_{CC}	-	V
		$V_{CC} = 2.3\text{ V}$; $I_{OH} = -8\text{ mA}$	1.8	2.5	-	V
V_{OL}	LOW-level output voltage	$V_{CC} = 2.3\text{ V}$; $I_{OL} = 100\text{ }\mu\text{A}$	-	0.07	0.2	V
		$V_{CC} = 2.3\text{ V}$; $I_{OL} = 24\text{ mA}$	-	0.3	0.5	V
		$V_{CC} = 2.3\text{ V}$; $I_{OL} = 8\text{ mA}$	-	-	0.4	V
$V_{OL(pu)}$	power-up LOW-level output voltage	$V_{CC} = 2.7\text{ V}$; $I_O = 1\text{ mA}$; $V_I = V_{CC}$ or GND	[2] -	-	0.55	V
I_{LI}	input leakage current	control pins				
		$V_{CC} = 2.7\text{ V}$; $V_I = V_{CC}$ or GND	-	0.1	± 1	μA
		$V_{CC} = 0\text{ V}$ to 2.7 V ; $V_I = 5.5\text{ V}$	-	0.1	10	μA
	I/O data pins	$V_{CC} = 2.7\text{ V}$; $V_I = V_{CC}$	[3] -	0.1	1	μA
		$V_{CC} = 2.7\text{ V}$; $V_I = 0\text{ V}$	[3] -	+0.1	-5	μA
I_{OFF}	off current	$V_{CC} = 0\text{ V}$; V_I or $V_O = 0\text{ V}$ to 4.5 V	-	+0.1	± 100	μA
I_{HOLD}	bus hold current data inputs	$V_{CC} = 2.3\text{ V}$; $V_I = 0.7\text{ V}$	[4] -	100	-	μA
		$V_{CC} = 2.3\text{ V}$; $V_I = 1.7\text{ V}$	[4] -	-70	-	μA
I_{EX}	external current into output	output HIGH-state when $V_O > V_{CC}$; $V_O = 5.5\text{ V}$; $V_{CC} = 2.3\text{ V}$	-	10	125	μA
I_{PU}	power-up 3-state output current	$V_{CC} \leq 1.2\text{ V}$; $V_O = 0.5\text{ V}$ to V_{CC} ; $V_I = \text{GND}$ or V_{CC}	[5] -	1	± 100	μA
I_{PD}	power-down 3-state output current	$V_{CC} \leq 1.2\text{ V}$; $V_O = 0.5\text{ V}$ to V_{CC} ; $V_I = \text{GND}$ or V_{CC}	[5] -	1	± 100	μA
I_{OZ}	3-state output current	$V_{CC} = 2.7\text{ V}$; $V_I = V_{IL}$ or V_{IH}				
		output HIGH state; $V_O = 2.3\text{ V}$	-	0.5	5	μA
		output LOW-state; $V_O = 0.5\text{ V}$	-	+0.5	-5	μA
I_{CC}	quiescent supply current	$V_{CC} = 2.7\text{ V}$; $V_I = \text{GND}$ or V_{CC} ; $I_O = 0\text{ A}$				
		outputs HIGH-state	-	0.04	0.1	mA
		outputs LOW-state	-	2.7	4.5	mA
		outputs disabled	[6] -	0.04	0.1	mA
ΔI_{CC}	additional quiescent supply current per input pin	$V_{CC} = 2.3\text{ V}$ to 2.7 V ; one input at $V_{CC} - 0.6\text{ V}$, other inputs at V_{CC} or GND	[7] -	0.04	0.4	mA
C_I	input capacitance	$V_I = 0\text{ V}$ or V_{CC}	-	3	-	pF
C_O	output capacitance	$V_{IO} = 0\text{ V}$ or 3.0 V	-	9	-	pF
$V_{CC} = 3.3\text{ V} \pm 0.3\text{ V}$ [8]						
V_{IK}	input clamping voltage	$V_{CC} = 3.0\text{ V}$; $I_{IK} = -18\text{ mA}$	-	-0.85	-1.2	V
V_{OH}	HIGH-level output voltage	$V_{CC} = 3.0\text{ V}$ to 3.6 V ; $I_{OH} = -100\text{ }\mu\text{A}$	$V_{CC} - 0.2$	V_{CC}	-	V
		$V_{CC} = 3.0\text{ V}$; $I_{OH} = -32\text{ mA}$	2.0	2.3	-	V

Table 7: Static characteristics ...continuedAt recommended operating conditions; voltages are referenced to GND (ground = 0 V); $T_{amb} = -40^{\circ}\text{C}$ to $+85^{\circ}\text{C}$.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
V_{OL}	LOW-level output voltage	$V_{CC} = 3.0\text{ V}; I_{OL} = 100\text{ }\mu\text{A}$	-	0.07	0.2	V
		$V_{CC} = 3.0\text{ V}; I_{OL} = 16\text{ mA}$	-	0.25	0.4	V
		$V_{CC} = 3.0\text{ V}; I_{OL} = 32\text{ mA}$	-	0.3	0.5	V
		$V_{CC} = 3.0\text{ V}; I_{OL} = 64\text{ mA}$	-	0.4	0.55	V
$V_{OL(pu)}$	power-up LOW-level output voltage	$V_{CC} = 3.6\text{ V}; I_O = 1\text{ mA}; V_I = V_{CC}$ or GND	[2] -	-	0.55	V
I_{LI}	input leakage current	control pins				
		$V_{CC} = 3.6\text{ V}; V_I = V_{CC}$ or GND	-	0.1	± 1	μA
		$V_{CC} = 0\text{ V}$ or $3.6\text{ V}; V_I = 5.5\text{ V}$	-	0.1	10	μA
	I/O data pins	$V_{CC} = 3.6\text{ V}; V_I = V_{CC}$	[3] -	0.5	1	μA
		$V_{CC} = 3.6\text{ V}; V_I = 0\text{ V}$	[3] -	+0.1	-5	μA
I_{OFF}	off current	$V_{CC} = 0\text{ V}; V_I$ or $V_O = 0\text{ V}$ to 4.5 V	-	0.1	± 100	μA
I_{HOLD}	bus hold current data inputs	$V_{CC} = 3\text{ V}; V_I = 0.8\text{ V}$	75	130	-	μA
		$V_{CC} = 3\text{ V}; V_I = 2.0\text{ V}$	-75	-140	-	μA
		$V_{CC} = 3.6\text{ V}; V_I = 0\text{V}$ to 3.6 V	[9] ± 500	-	-	μA
I_{EX}	external current into output	output HIGH-state when $V_O > V_{CC}$; $V_O = 5.5\text{ V}; V_{CC} = 3.0\text{ V}$	-	10	125	μA
I_{PU}	power-up 3-state output current	$V_{CC} \leq 1.2\text{ V}; V_O = 0.5\text{ V}$ to V_{CC} ; $V_I = \text{GND}$ or V_{CC}	[10] -	1	± 100	μA
I_{PD}	power-down 3-state output current	$V_{CC} \leq 1.2\text{ V}; V_O = 0.5\text{ V}$ to V_{CC} ; $V_I = \text{GND}$ or V_{CC}	[10] -	1	± 100	μA
I_{OZ}	3-state output current	$V_{CC} = 3.6\text{ V}; V_I = V_{IL}$ or V_{IH}				
		output HIGH state; $V_O = 3.0\text{ V}$	-	0.5	5	μA
		output LOW-state; $V_O = 0.5\text{ V}$	-	+0.5	-5	μA
I_{CC}	quiescent supply current	$V_{CC} = 3.6\text{ V}; V_I = \text{GND}$ or $V_{CC}; I_O = 0\text{ A}$				
		outputs HIGH-state	-	0.06	0.1	mA
		outputs LOW-state	-	3.9	5.5	mA
		outputs disabled	[6] -	0.06	0.1	mA
ΔI_{CC}	additional quiescent supply current per input pin	$V_{CC} = 3\text{ V}$ to 3.6 V ; one input at $V_{CC} - 0.6\text{ V}$, other inputs at V_{CC} or GND	[7] -	0.04	0.4	mA
C_I	input capacitance	$V_I = 0\text{ V}$ or V_{CC}	-	3	-	pF
C_O	output capacitance	$V_{IO} = 0\text{ V}$ or 3.0 V	-	9	-	pF

[1] All typical values are at $V_{CC} = 2.5\text{ V}$ and $T_{amb} = 25^{\circ}\text{C}$.

[2] For valid test results, data must not be loaded into the flip-flops (or latches) after applying power.

[3] Unused pins at V_{CC} or GND.

[4] Not guaranteed.

[5] This parameter is valid for any V_{CC} between 0 V and 1.2 V with a transition time of up to 10 ms . From $V_{CC} = 1.2\text{ V}$ to $V_{CC} = 2.5\text{ V} \pm 0.2\text{ V}$ a transition time of $100\text{ }\mu\text{s}$ is permitted. This parameter is valid for $T_{amb} = 25^{\circ}\text{C}$ only.[6] I_{CC} is measured with outputs pulled up to V_{CC} or pulled down to ground.[7] This is the increase in supply current for each input at the specified voltage level other than V_{CC} or GND.[8] All typical values are at $V_{CC} = 3.3\text{ V}$ and $T_{amb} = 25^{\circ}\text{C}$.

[9] This is the bus hold overdrive current required to force the input to the opposite logic state.

[10] This parameter is valid for any V_{CC} between 0 V and 1.2 V with a transition time of up to 10 ms. From $V_{CC} = 1.2$ V to $V_{CC} = 3.3$ V ± 0.3 V a transition time of 100 μ s is permitted. This parameter is valid for $T_{amb} = 25$ °C only.

11. Dynamic characteristics

Table 8: Dynamic characteristics

Voltages are referenced to GND (ground = 0 V); for test circuit see [Figure 10](#);

$T_{amb} = -40$ °C to $+85$ °C.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$V_{CC} = 2.5$ V ± 0.2 V [1]						
f_{max}	maximum clock frequency	see Figure 5	150	-	-	MHz
t_{PLH}	propagation delay nCP to nQx	see Figure 5	1.5	2.9	4.5	ns
t_{PHL}	HIGH-to-LOW propagation delay					
	nCP to nQx	see Figure 5	1.4	2.7	4.2	ns
	nMR to nQx	see Figure 7	1.5	2.7	4.2	ns
t_{PZH}	output enable time to HIGH-level	see Figure 8	2.1	3.4	5.0	ns
t_{PZL}	output enable time to LOW-level	see Figure 9	1.8	3.0	4.7	ns
t_{PHZ}	output disable time from HIGH-level	see Figure 8	1.7	3.0	4.3	ns
t_{PLZ}	output disable time from LOW-level	see Figure 9	1.4	2.3	3.3	ns
$t_{su(H)}$	set-up time HIGH					
	nDx to nCP	see Figure 6	1.0	0.5	-	ns
	nCE to nCP	see Figure 6	1.0	0.2	-	ns
$t_{su(L)}$	set-up time LOW					
	nDx to nCP	see Figure 6	1.8	1.3	-	ns
	nCE to nCP	see Figure 6	+0.5	-0.1	-	ns
$t_{h(H)}$	hold time HIGH					
	nDx to nCP	see Figure 6	+0.1	-1.4	-	ns
	nCE to nCP	see Figure 6	1.0	0.2	-	ns
$t_{h(L)}$	hold time LOW					
	nDx to nCP	see Figure 6	+0.1	-0.5	-	ns
	nCE to nCP	see Figure 6	+1.0	-0.1	-	ns
t_{WH}	pulse width HIGH nCP	see Figure 5	2.0	0.8	-	ns
t_{WL}	pulse width LOW					
	nCP	see Figure 5	3.0	2.1	-	ns
	nMR	see Figure 7	2.0	0.8	-	ns
t_{rec}	recovery time nMR to nCP	see Figure 7	2.0	1.3	-	ns
$V_{CC} = 3.3$ V ± 0.3 V [2]						
f_{max}	maximum clock frequency	see Figure 5	250	-	-	MHz
t_{PLH}	propagation delay nCP to nQx	see Figure 5	1.0	2.3	3.1	ns
t_{PHL}	HIGH-to-LOW propagation delay					
	nCP to nQx	see Figure 5	1.0	2.1	2.9	ns
	nMR to nQx	see Figure 7	1.0	2.3	2.9	ns
t_{PZH}	output enable time to HIGH-level	see Figure 8	1.7	2.7	4.0	ns
t_{PZL}	output enable time to LOW-level	see Figure 9	1.4	2.3	3.5	ns

Table 8: Dynamic characteristics ...continued

Voltages are referenced to GND (ground = 0 V); for test circuit see [Figure 10](#);

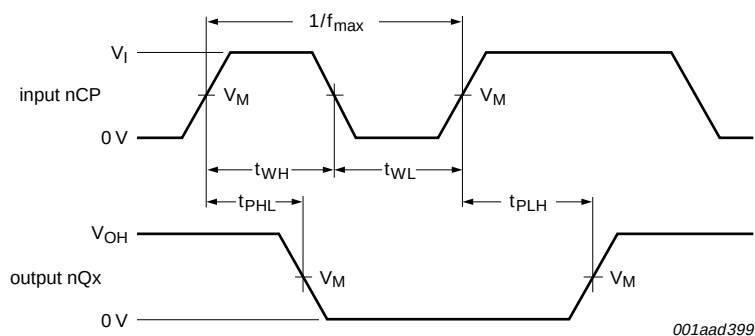
$T_{amb} = -40\text{ }^{\circ}\text{C}$ to $+85\text{ }^{\circ}\text{C}$.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
t_{PHZ}	output disable time from HIGH-level	see Figure 8	2.2	3.1	4.0	ns
t_{PLZ}	output disable time from LOW-level	see Figure 9	1.8	2.6	3.5	ns
$t_{su(H)}$	set-up time HIGH					
	nDx to nCP	see Figure 6	1.0	0.5	-	ns
	$\overline{\text{nCE}}$ to nCP	see Figure 6	1.0	0.1	-	ns
$t_{su(L)}$	set-up time LOW					
	nDx to nCP	see Figure 6	1.6	1.1	-	ns
	$\overline{\text{nCE}}$ to nCP	see Figure 6	+0.5	-0.5	-	ns
$t_{h(H)}$	hold time HIGH					
	nDx to nCP	see Figure 6	+0.1	-0.7	-	ns
	$\overline{\text{nCE}}$ to nCP	see Figure 6	1.0	0.5	-	ns
$t_{h(L)}$	hold time LOW					
	nDx to nCP	see Figure 6	+0.1	-0.5	-	ns
	$\overline{\text{nCE}}$ to nCP	see Figure 6	+1.0	-0.1	-	ns
t_{WH}	pulse width HIGH nCP	see Figure 5	1.5	0.7	-	ns
t_{WL}	pulse width LOW					
	nCP	see Figure 5	2.5	1.4	-	ns
	$\overline{\text{nMR}}$	see Figure 7	2.0	1.5	-	ns
t_{rec}	recovery time $\overline{\text{nMR}}$ to nCP	see Figure 7	2.0	1.1	-	ns

[1] All typical values are measured at $V_{CC} = 2.5\text{ V}$ and $T_{amb} = 25\text{ }^{\circ}\text{C}$.

[2] All typical values are measured at $V_{CC} = 3.3\text{ V}$ and $T_{amb} = 25\text{ }^{\circ}\text{C}$.

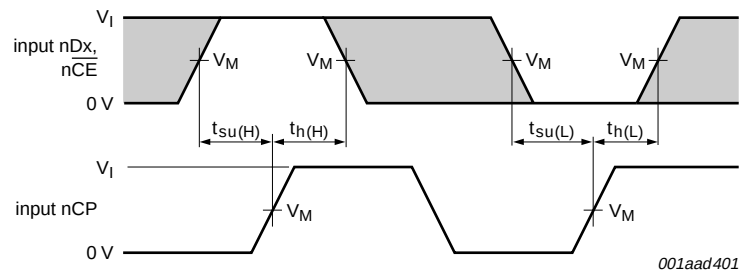
12. Waveforms



Measurement points are given in [Table 9](#).

V_{OH} is a typical voltage output drop that occur with the output load.

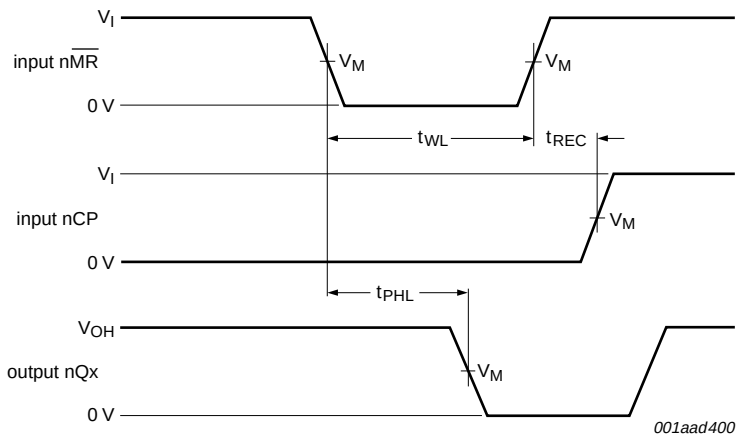
Fig 5. Propagation delay, clock input to output, clock pulse width and maximum clock frequency



Measurement points are given in [Table 9](#).

The shaded areas indicate when the input is permitted to change for predictable output performance.

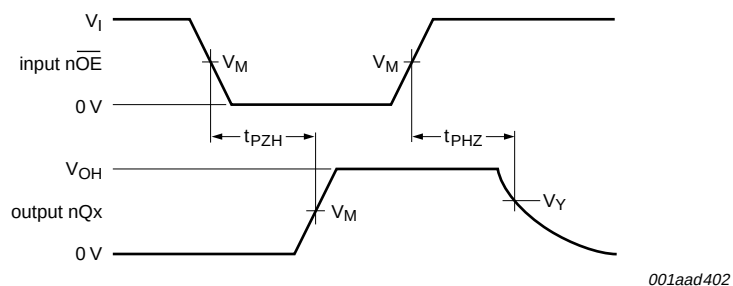
Fig 6. Data set-up and hold times



Measurement points are given in [Table 9](#).

V_{OH} is a typical voltage output drop that occur with the output load.

Fig 7. Master reset pulse width, master reset to output delay and master reset to clock recovery time



Measurement points are given in [Table 9](#).

V_{OH} is a typical voltage output drop that occur with the output load.

Fig 8. 3-state output enable time to HIGH-level and output disable time from HIGH-level

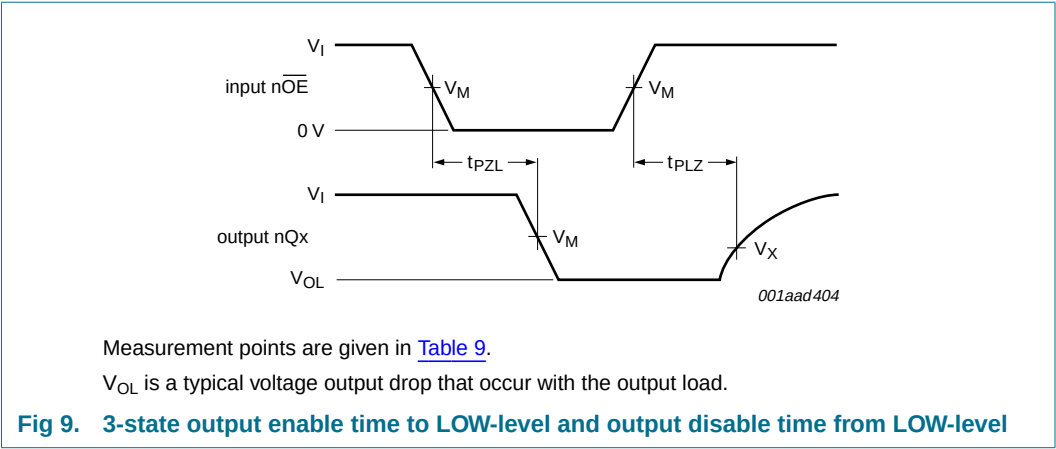


Table 9: Measurement points

Supply voltage	Input	Output		
	V_M	V_M	V_X	V_Y
$\geq 3\text{ V}$	1.5 V	1.5 V	$V_{OL} + 0.3\text{ V}$	$V_{OH} - 0.3\text{ V}$
$\leq 2.7\text{ V}$	$0.5 \times V_{CC}$	$0.5 \times V_{CC}$	$V_{OL} + 0.3\text{ V}$	$V_{OH} - 0.3\text{ V}$

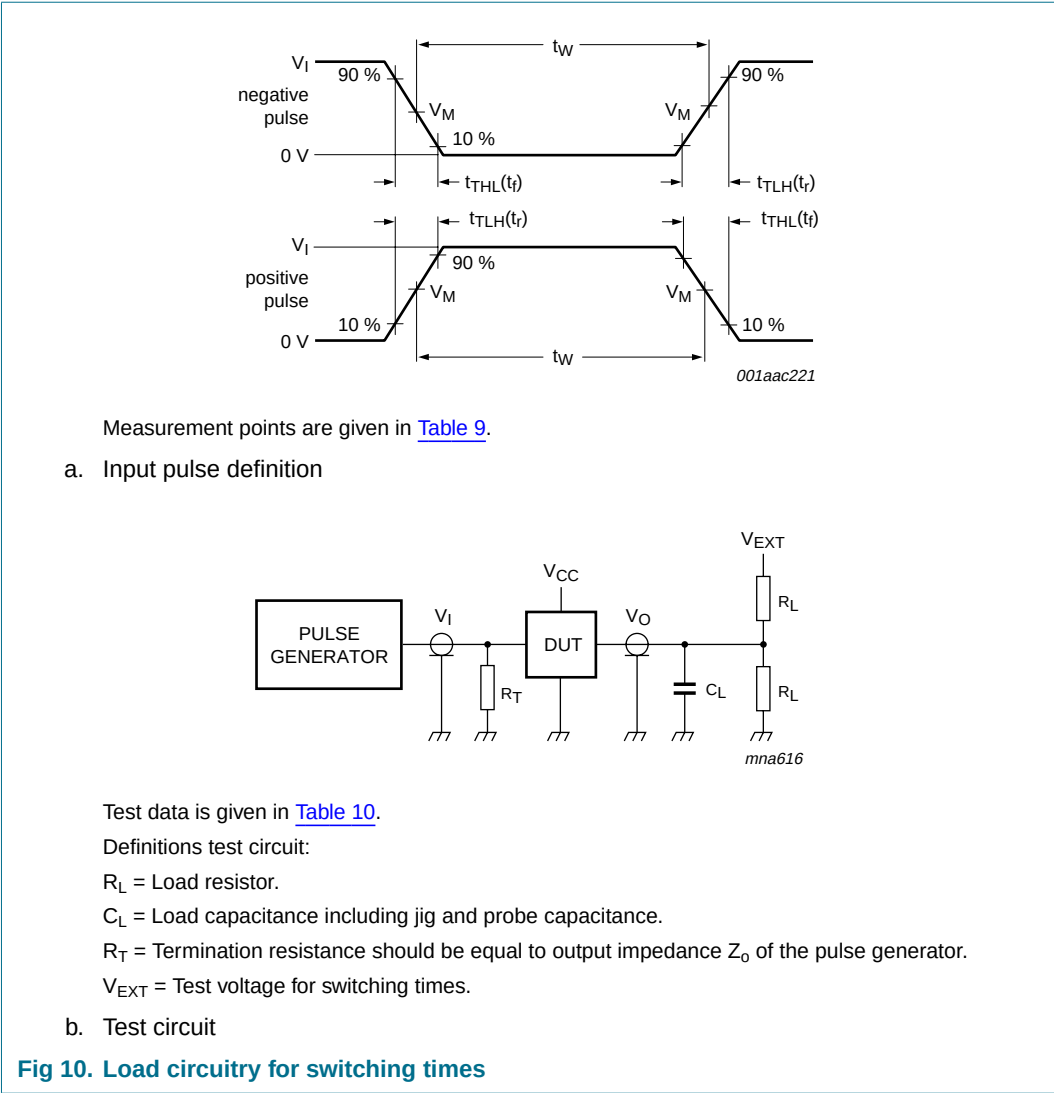


Table 10: Test data

Input				Load		V_{EXT}			
V_I	f_i	t_W	t_r, t_f	C_L	R_L	t_{PLZ}, t_{PZL}	t_{PLH}, t_{PHL}	t_{PHZ}, t_{PZH}	
3.0 V or V_{CC} whichever is less	≤ 10 MHz	500 ns	≤ 2.5 ns	50 pF	500 Ω	6 V or $2 \times V_{CC}$	open	GND	

13. Package outline

SSOP56: plastic shrink small outline package; 56 leads; body width 7.5 mm

SOT371-1

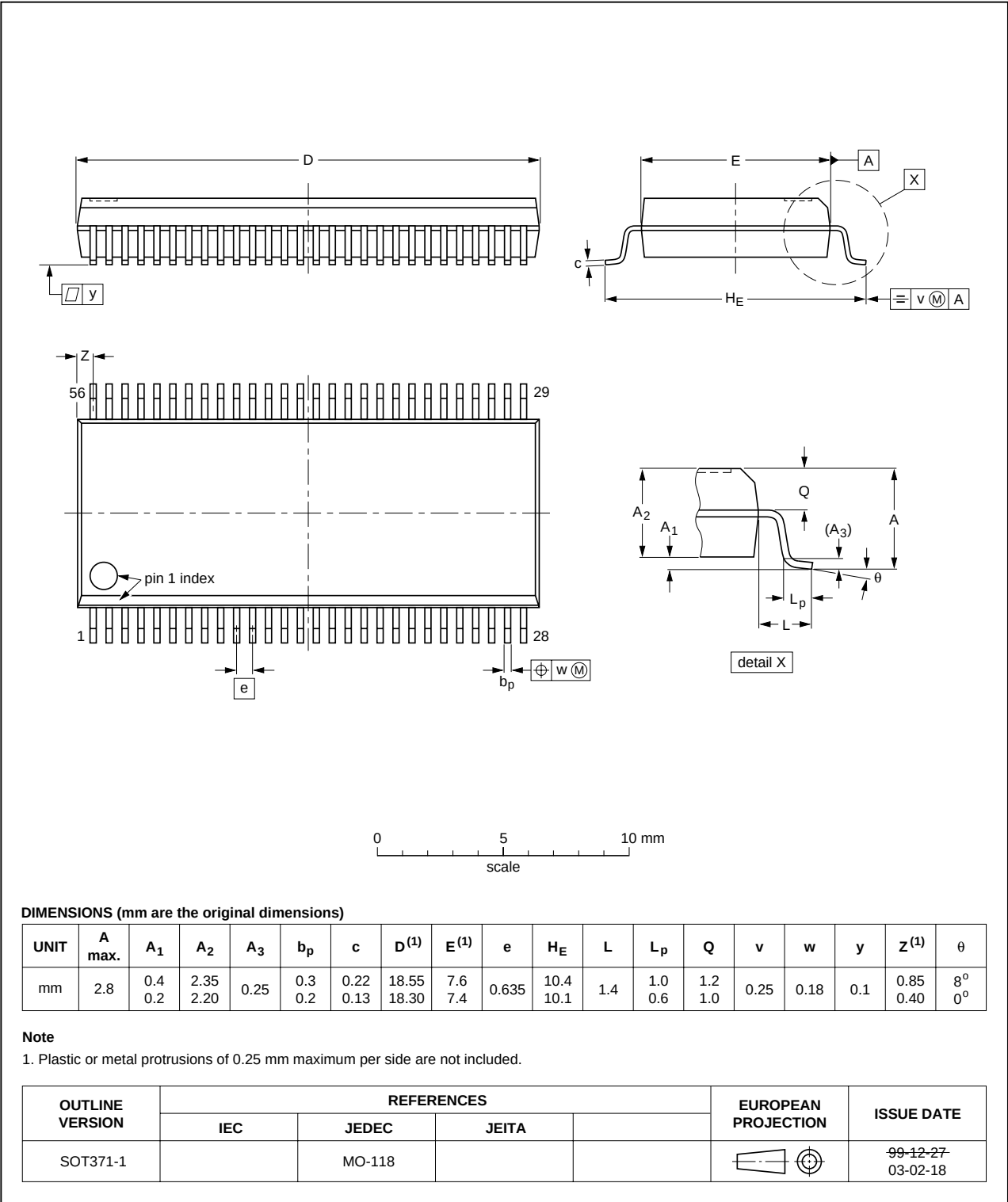


Fig 11. Package outline SOT371-1 (SSOP56)



TSSOP56: plastic thin shrink small outline package; 56 leads; body width 6.1 mm

SOT364-1

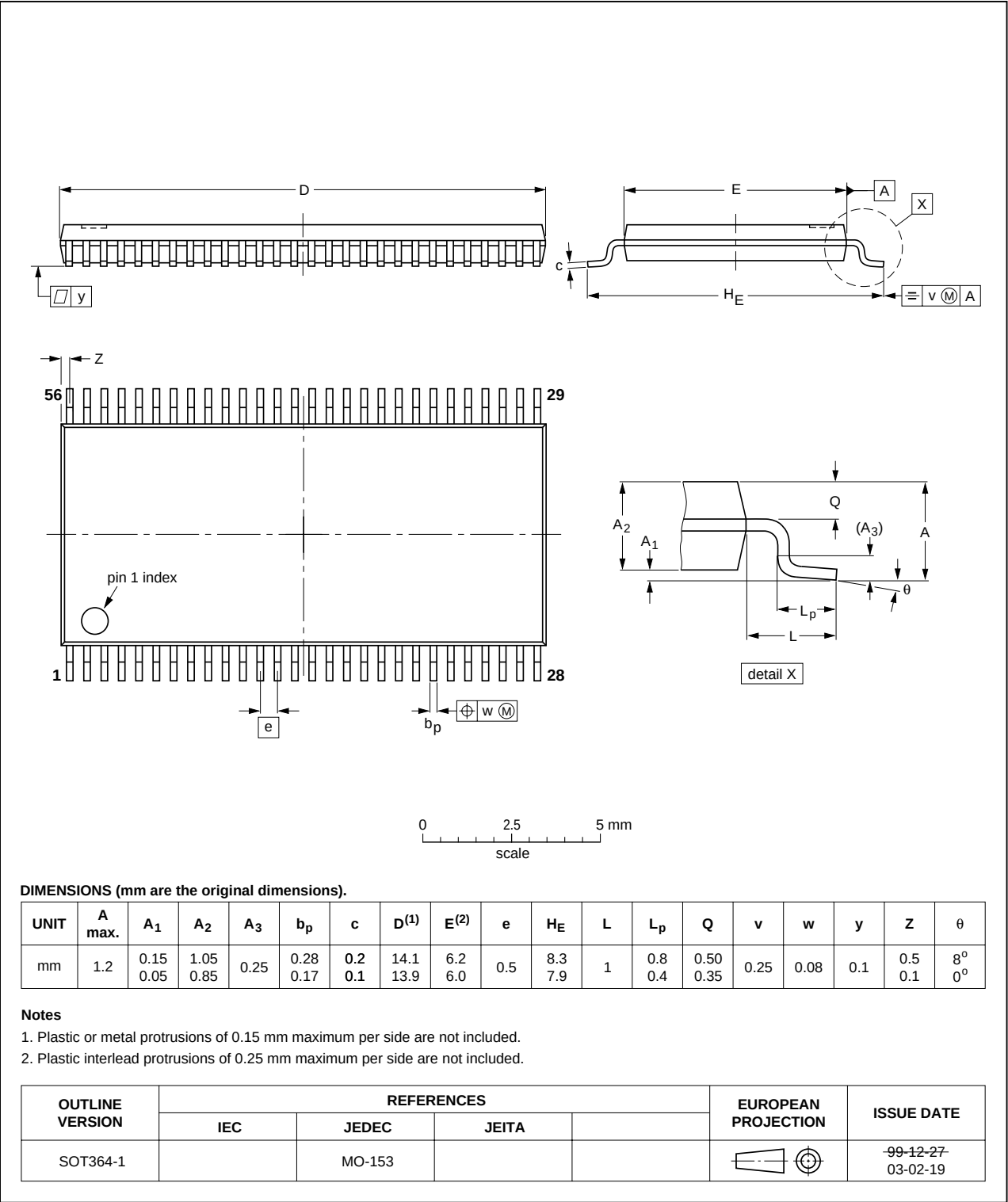


Fig 12. Package outline SOT364-1 (TSSOP56)



14. Revision history

Table 11: Revision history

Document ID	Release date	Data sheet status	Change notice	Doc. number	Supersedes
74ALVT16823_4	20050802	Product data sheet	-	-	74ALVT16823_3
Modifications:					
- The format of this data sheet has been redesigned to comply with the new presentation and information standard of Philips Semiconductors. Section 2: modified 'Jedec Std 17' into 'JESD78' Table 8: changed propagation delays.					
74ALVT16823_3	19980612	Product specification	-	9397 750 04016	74ALVT16823_2
74ALVT16823_2	19980612	Product specification	-	9397 750 04016	74ALVT16823
74ALVT16823	19980303	-	-	-	-

15. Data sheet status

Level	Data sheet status ^[1]	Product status ^{[2] [3]}	Definition
I	Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
II	Preliminary data	Qualification	This data sheet contains data from the preliminary specification. Supplementary data will be published at a later date. Philips Semiconductors reserves the right to change the specification without notice, in order to improve the design and supply the best possible product.
III	Product data	Production	This data sheet contains data from the product specification. Philips Semiconductors reserves the right to make changes at any time in order to improve the design, manufacturing and supply. Relevant changes will be communicated via a Customer Product/Process Change Notification (CPCN).

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[2] The product status of the device(s) described in this data sheet may have changed since this data sheet was published. The latest information is available on the Internet at URL <http://www.semiconductors.philips.com>.

[3] For data sheets describing multiple type numbers, the highest-level product status determines the data sheet status.

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